TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

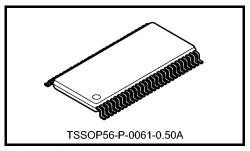
# **TC74VCXH16543FT**

#### Low-Voltage 16-Bit Registered Transceiver with Bushold

The TC74VCXH16543FT is a high-performance CMOS 16-bit registered transceiver. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

The TC74VCXH16543FT can be used as two 8-bit transceivers or one 16-bit transceiver. Separate latch-enable ( $\overline{\text{LEAB}}$  or  $\overline{\text{LEBA}}$ ) and output-enable ( $\overline{\text{OEAB}}$  or  $\overline{\text{OEBA}}$ ) inputs are provided for each register to permit independent control in either direction of data flow.

The A-to-B enable (CEAB) input must be low in order to enter data from A or to output data from B. If CEAB is low and LEAB is low, the A-to-B latches are transparent; a subsequent



Weight: 0.25 g (typ.)

low-to-high transition of  $\overline{LEAB}$  puts the Alatches in the storage mode. With  $\overline{CEAB}$  and  $\overline{OEAB}$  both low, the 3-state B outputs are active and reflect the data present at the output of the A latches.

Data flow from B to A is similar but requires using the CEBA, LEBA, and OEAB inputs.

When the OE input is high, the outputs are in a high-impedance state. This device is designed to be used with 3-state memory address drivers, etc.

The A, B data inputs include active bushold circuitry, eliminating the need for external pull-up resistors to hold unused or floating data inputs at a valid logic level.

All inputs are equipped with protection circuits against static discharge.

#### Features (Note)

- Low-voltage operation: V<sub>CC</sub> = 1.8 to 3.6 V
- Bushold on data inputs eliminating the need for external pull-up/pull-down resistors
- High-speed operation:  $t_{pd} = 3.5 \text{ ns (max) (V}_{CC} = 3.0 \text{ to } 3.6 \text{ V)}$

 $t_{pd} = 4.0 \text{ ns (max) (VCC} = 2.3 \text{ to } 2.7 \text{ V)}$ 

 $: t_{pd} = 8.0 \text{ ns (max) (VCC} = 1.8 \text{ V)}$ 

- 3.6-V tolerant control inputs
- Output current:  $I_{OH}/I_{OL} = \pm 24 \text{ mA (min) (V}_{CC} = 3.0 \text{ V)}$

 $: I_{OH}/I_{OL} = \pm 18 \text{ mA (min) (V}_{CC} = 2.3 \text{ V)}$ 

:  $I_{OH}/I_{OL} = \pm 6 \text{ mA (min) (V}_{CC} = 1.8 \text{ V)}$ 

- Latch-up performance: -300 mA
- ESD performance: Machine model  $\geq \pm 200 \text{ V}$

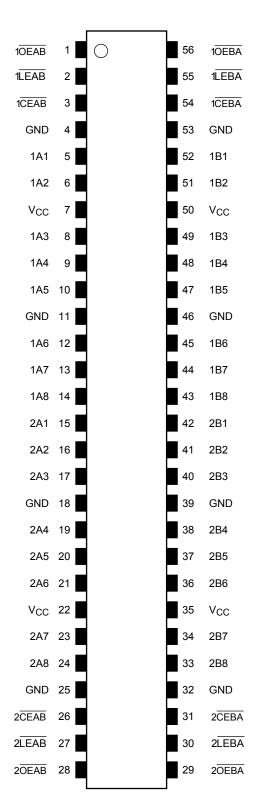
Human body model  $\geq \pm 2000 \text{ V}$ 

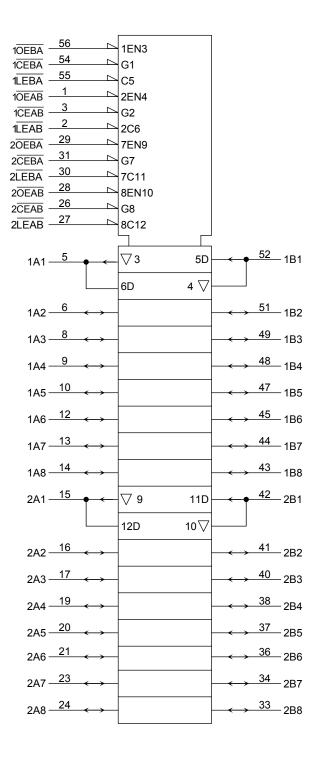
Package: TSSOP

Note: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

## Pin Assignment (top view)

## **IEC Logic Symbol**





## Truth Table (A bus → B bus each 8-bit latch)

	Inputs						
CEAB	LEAB	OEAB	Α	В			
Н	Х	Х	Х	Z			
Х	Х	Н	Х	Z			
	Н		Х	B0			
L	П	L	^	(Note)			
L	L	L	L	L			
L	L	L	Н	Н			

Note: Output level before the indicated steady-state input conditions were established.

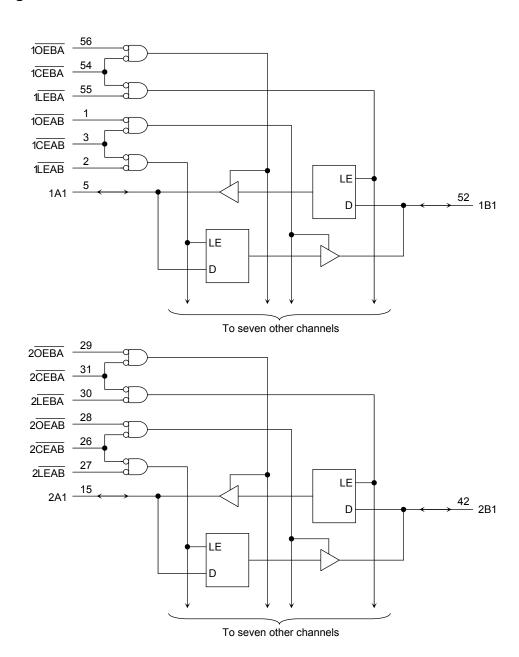
## Truth Table (B bus → A bus each 8-bit latch)

	Inputs						
CEBA	LEBA	OEBA	В	Α			
Н	Х	Х	Х	Z			
Х	Х	Н	Х	Z			
	Н		X	A0			
L	П	L	^	(Note)			
L	L	L	L	L			
L	L	L	Н	Н			

Note: Output level before the indicated steady-state input conditions were established.

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## **System Diagram**





### **Absolute Maximum Ratings (Note 1)**

Characteristics		Symbol	Rating	Unit	
Power sup	oply voltage	V <sub>CC</sub>	-0.5 to 4.6	V	
DC input	(OEAB, OEBA, LEAB, LEBA, CEBA)		-0.5 to 4.6		
voltage	(An Rn)	V <sub>IN</sub>	-0.5 to V <sub>CC</sub> + 0.5	V	
	(An, Bn)		(Note 2)		
DC	(An Dn)	V	-0.5 to V <sub>CC</sub> + 0.5		
output voltage	(An, Bn)	V <sub>OUT</sub>	(Note 3)	V	
Input diod	e current	I <sub>IK</sub>	-50	mA	
Output dic	ode current	I <sub>OK</sub>	±50 (Note 4)	mA	
Output current		lout	±50	mA	
Power dissipation		P <sub>D</sub>	400	mW	
DC V <sub>CC</sub> /ground current per supply pin		I <sub>CC</sub> /I <sub>GND</sub>	±100	mA	
Storage to	emperature	T <sub>stg</sub>	-65 to 150	°C	

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: OFF state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4:  $V_{OUT} < GND$ ,  $V_{OUT} > V_{CC}$ 



### **Operating Ranges (Note 1) (Note 2)**

Characteristics		Characteristics Symbol		Unit
Power su	oply voltage	V <sub>CC</sub>	1.8 to 3.6	V
i ower su	oply voltage	VCC	1.2 to 3.6 (Note 3)	V
Input voltage	(OEAB, OEBA, LEAB, LEBA, CEBA)	-0.3 to 3.6		٧
voitage	(An, Bn)		0 to V <sub>CC</sub> (Note 4)	
Output voltage	(An, Bn)	V <sub>OUT</sub>	V <sub>OUT</sub> 0 to V <sub>CC</sub> (Note 5)	
			±24 (Note 6)	
Output cu	Output current		±18 (Note 7)	mA
			±6 (Note 8)	
Operating temperature		T <sub>opr</sub>	-40 to 85	°C
Input rise	and fall time	dt/dv	0 to 10 (Note 9)	ns/V

- Note 1: The operating ranges must be maintained to ensure the normal operation of the device.

  Unused inputs must be tied to either VCC or GND.
- Note 2: Floating or unused control inputs must be held high or low.
- Note 3: Data retention only
- Note 4: OFF state
- Note 5: High or low state
- Note 6:  $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$
- Note 7:  $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$
- Note 8:  $V_{CC} = 1.8 \text{ V}$
- Note 9:  $V_{IN} = 0.8$  to 2.0 V,  $V_{CC} = 3.0$  V

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#### **Electrical Characteristics**

## DC Characteristics (Ta = -40 to 85°C, 2.7 V < V<sub>CC</sub> $\leq$ 3.6 V)

Characteristi	cs	Symbol	Test C	Test Condition		Min	Max	Unit		
Input voltage	H-level	V <sub>IH</sub>	-	_	2.7 to 3.6	2.0	_	V		
input voltage	L-level	V <sub>IL</sub>	-	_	2.7 to 3.6	_	0.8	V		
				I <sub>OH</sub> = -100 μA	2.7 to 3.6	V <sub>CC</sub> - 0.2	_			
	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -12 mA	2.7	2.2	_			
				I <sub>OH</sub> = -18 mA	3.0	2.4	_			
Output voltage				$I_{OH} = -24 \text{ mA}$	3.0	2.2	_	V		
				$I_{OL} = 100 \ \mu A$	2.7 to 3.6		0.2			
	L-level	V <sub>OL</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	V. V. or V.	I <sub>OL</sub> = 12 mA	I <sub>OL</sub> = 12 mA	2.7		0.4	
	L-level	VOL		I <sub>OL</sub> = 18 mA	3.0	_	0.4			
				I <sub>OL</sub> = 24 mA			0.55			
Input leakage current (OEAB, OEBA, LEA		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		2.7 to 3.6	_	±5.0	μА		
Bushold input minimun	n drive hold		V <sub>IN</sub> = 0.8 V		3.0	75	_	^		
current		I <sub>I</sub> (HOLD)	V <sub>IN</sub> = 2.0 V		3.0	-75	_	μА		
Bushold input over-driv	e current to	1		(Note 1)	3.6	_	450	^		
change state	hange state		(Note 2)	3.6	_	-450	μА			
3-state output OFF sta	te current	l <sub>OZ</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = V_{CC}$ or GND		2.7 to 3.6	_	±10.0	μА		
Quiescent supply curre	ent	Icc	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.7 to 3.6	_	20.0	μΑ		
Increase in I <sub>CC</sub> per inp	ut	Δlcc	$V_{IH} = V_{CC} - 0.6 V$		2.7 to 3.6		750	μΑ		

Note 1: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 2: An external driver must sink at least the specified current to switch from HIGH-to-LOW.



## DC Characteristics (Ta = -40 to 85°C, 2.3 V $\leq$ V<sub>CC</sub> $\leq$ 2.7 V)

Characteristi	cs	Symbol	Test C	ondition	V <sub>CC</sub> (V)	Min	Max	Unit		
lanut valta a	H-level	V <sub>IH</sub>	-	_	2.3 to 2.7	1.6	_	V		
Input voltage	L-level	V <sub>IL</sub>	-	_	2.3 to 2.7	_	0.7	V		
				I <sub>OH</sub> = -100 μA	2.3 to 2.7	V <sub>CC</sub> - 0.2	_			
	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	$I_{OH} = -6 \text{ mA}$	2.3	2.0	_			
				I <sub>OH</sub> = -12 mA	2.3	1.8	_			
Output voltage				I <sub>OH</sub> = -18 mA	2.3	1.7	_	V		
				$I_{OL} = 100 \ \mu A$	2.3 to 2.7	_	0.2			
	L-level	V <sub>OL</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$ $I_{OL} = 12 \text{ mA}$ 2.3 $I_{OL} = 18 \text{ mA}$ 2.3	$V_{IN} = V_{IH}$ or $V_{IL}$	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $I_{OL} = 12 \text{ mA}$	I <sub>OL</sub> = 12 mA	2.3	_	0.4	
				_	0.6					
Input leakage current (OEAB, OEBA, LEAL LEBA, CEAB, CEA	\ <u>\B</u> , BA)	I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		2.3 to 2.7	_	±5.0	μА		
Bushold input minimum	n drive hold		V <sub>IN</sub> = 0.7 V		2.3	45	_			
current		I (HOLD)	V <sub>IN</sub> = 1.6 V		2.3	-45	_	μΑ		
Bushold input over-driv	t over-drive current to . (Note 1)		2.7	_	300	^				
change state		(Note 2		(Note 2)		_	-300	μА		
3-state output OFF state	te current	I <sub>OZ</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = V_{CC}$ or GND		2.3 to 2.7	_	±10.0	μА		
Quiescent supply curre	nt	Icc	$V_{IN} = V_{CC}$ or GND		2.3 to 2.7	_	20.0	μΑ		

Note 1: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 2: An external driver must sink at least the specified current to switch from HIGH-to-LOW.



## DC Characteristics (Ta = -40 to 85°C, 1.8 V $\leq$ V<sub>CC</sub> < 2.3 V)

Characteristi	ics	Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>	_	_	1.8 to 2.3	0.7 × V <sub>CC</sub>	_	V
input voitage	L-level	V <sub>IL</sub>	_	_	1.8 to 2.3		0.2 × V <sub>CC</sub>	V
	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	1.8	V <sub>CC</sub> - 0.2	ı	
Output voltage				$I_{OH} = -6 \text{ mA}$	1.8	1.4		V
	L-level	V/	V. V. or V.	$I_{OL} = 100 \mu A$	1.8	_	0.2	
	L-level	V <sub>OL</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OL</sub> = 6 mA	1.8	_	0.3	
Input leakage current (OEAB, OEBA, LEBA, CEAB, CEAB		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		1.8	_	±5.0	μА
Bushold input minimun	n drive hold		V <sub>IN</sub> = 0.36 V		1.8	25	_	^
current		II (HOLD)	$V_{IN} = 1.26 \text{ V}$		1.8	-25	_	μА
Bushold input over-drive current to change state		1		(Note 1)	1.8	_	200	
		I <sub>I</sub> (OD)		(Note 2)	1.8	_	-200	μА
3-state output OFF state current		I <sub>OZ</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or GND}$		1.8	_	±10.0	μΑ
Quiescent supply curre	ent	Icc	V <sub>IN</sub> = V <sub>CC</sub> or GND		1.8		20.0	μΑ

Note 1: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 2: An external driver must sink at least the specified current to switch from HIGH-to-LOW.



## AC Characteristics (Ta = –40 to 85°C, input: $t_r = t_f$ = 2.0 ns, $C_L$ = 30 pF, $R_L$ = 500 $\Omega$ ) (Note 1)

Characteristics	Symbol	Test Condition		Min	Max	Unit		
Characteristics	Symbol	DOI TEST CONTRIBUTI		V <sub>CC</sub> (		IVIIII	IVIAX	Oill
Propagation delay time	<b>+</b>		1.8	1.5	8.0			
(An, Bn-Bn, An)	t <sub>pLH</sub> t <sub>pHL</sub>	Figure 1, Figure 2	$2.5 \pm 0.2$	8.0	4.0	ns		
(אוו, טוויטוו, אוו)	чрнс		$3.3 \pm 0.3$	0.6	3.5			
Draw and in a dalay time			1.8	1.5	9.8			
Propagation delay time (LEAB, LEBA -Bn, An)	t <sub>pLH</sub>	Figure 1, Figure 2	$2.5 \pm 0.2$	0.8	5.0	ns		
(LEAD, LEDA-DII, AII)	t <sub>pHL</sub>		$3.3 \pm 0.3$	0.6	3.9			
3-state output enable time			1.8	1.5	9.8			
(OEAB, OEBA, CEAB,	t <sub>pZL</sub>	Figure 1, Figure 4	$2.5\pm0.2$	0.8	4.9	ns		
CEBA)	<sup>t</sup> pZH		$3.3 \pm 0.3$	0.6	3.8			
3-state output disable time			1.8	1.5	7.6	ns		
(OEAB, OEBA, CEAB,	t <sub>pLZ</sub> t <sub>pHZ</sub>	Figure 1, Figure 4	$2.5\pm0.2$	0.8	4.2			
CEBA)			$3.3 \pm 0.3$	0.6	3.7			
Minimum mula a cuidale			1.8	4.0	_			
Minimum pulse width ( LEAB , LEBA , CEAB , CEBA )	t <sub>W (L)</sub>	Figure 1, Figure 2, Figure 3	$2.5 \pm 0.2$	1.5	_	ns		
(LEAD, LEBA, CEAD, CEBA)			$3.3 \pm 0.3$	1.5	_			
Minimum action time			1.8	2.5	_			
Minimum setup time  (An, Bn- $\overline{LE}$ , $\overline{CE}$ )	ts	Figure 1, Figure 2, Figure 3	$2.5\pm0.2$	1.5	_	ns		
(AII, BII-LE, CE)			$3.3 \pm 0.3$	1.5	_			
Minimum In a lat time a			1.8	1.0				
Minimum hold time  (An, Bn- LE, CE)	t <sub>h</sub>	Figure 1, Figure 2, Figure 3	$2.5 \pm 0.2$	1.0	_	ns		
(AII, BII-LE, CE)			$3.3 \pm 0.3$	1.0	_			
			1.8	_	0.5			
Output to output skew	t <sub>osLH</sub>	(Note 2)	$2.5 \pm 0.2$	_	0.5	ns		
	t <sub>osHL</sub>		$3.3 \pm 0.3$	_	0.5			

Note 1: For  $C_L = 50 \ pF$ , add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.  $(t_{OSLH} = |t_{DLHm} - t_{DLHn}|, \ t_{OSHL} = |t_{DHLm} - t_{DHLn}|)$ 



## Dynamic Switching Characteristics

(Ta = 25°C, input:  $t_r = t_f = 2.0$  ns,  $C_L = 30$  pF,  $R_L = 500$  Ω)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Unit
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (No	e) 1.8	0.25	
Quiet output maximum dynamic V <sub>OL</sub>	$V_{OLP}$	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (No	e) 2.5	0.6	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (No	e) 3.3	0.8	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (No	e) 1.8	-0.25	
Quiet output minimum dynamic V <sub>OI</sub>	$V_{OLV}$	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (No	e) 2.5	-0.6	V
, 32		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (No	e) 3.3	-0.8	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (No	e) 1.8	1.5	
Quiet output minimum dynamic V <sub>OH</sub>	V <sub>OHV</sub>	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (No	e) 2.5	1.9	V
, o		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (No	e) 3.3	2.2	

Note: Parameter guaranteed by design.

### **Capacitive Characteristics (Ta = 25°C)**

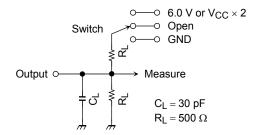
Characteristics	Symbol	Test Condition			Tun	Unit
Characteristics	Syllibol			V <sub>CC</sub> (V)	Тур.	Offic
Input capacitance	C <sub>IN</sub>			1.8, 2.5, 3.3	6	pF
Bus I/O capacitance	C <sub>I/O</sub>	<del>_</del>		1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C <sub>PD</sub>	f <sub>IN</sub> = 10 MHz	(Note)	1.8, 2.5, 3.3	20	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/16 \text{ (per bit)}$ 

#### **AC Test Circuit**



Parameter	Switch			
t <sub>pLH</sub> , t <sub>pHL</sub>	Open			
t <sub>pLZ</sub> , t <sub>pZL</sub>	6.0 V V <sub>CC</sub> × 2	$@V_{CC} = 3.3 \pm 0.3 \text{ V} \\ @V_{CC} = 2.5 \pm 0.2 \text{ V} \\ @V_{CC} = 1.8 \text{ V}$		
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND			

Figure 1

#### **AC Waveform**

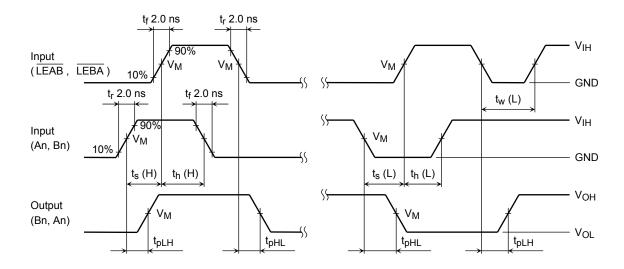


Figure 2  $t_{pLH}, t_{pHL}, t_w, t_s, t_h$ 

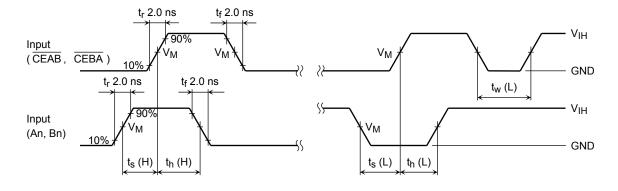


Figure 3 tw, ts, th

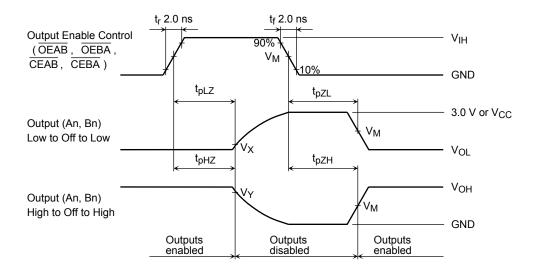
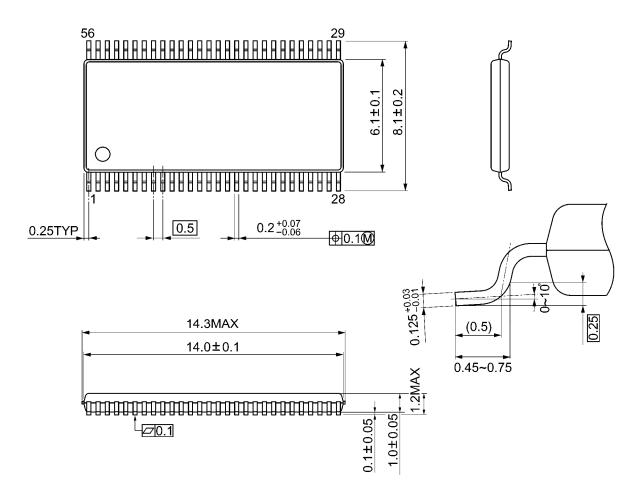


Figure 4  $t_{\text{pLZ}},\,t_{\text{pHZ}},\,t_{\text{pZL}},\,t_{\text{pZH}}$ 

Symbol		V <sub>CC</sub>	
Syllibol	$3.3\pm0.3~\textrm{V}$	$2.5\pm0.2\textrm{V}$	1.8 V
$V_{IH}$	2.7 V	V <sub>CC</sub>	V <sub>CC</sub>
V <sub>M</sub>	1.5 V	V <sub>CC</sub> /2	V <sub>CC</sub> /2
VX	V <sub>OL</sub> + 0.3 V	V <sub>OL</sub> + 0.15 V	V <sub>OL</sub> + 0.15 V
VY	V <sub>OH</sub> – 0.3 V	V <sub>OH</sub> – 0.15 V	V <sub>OH</sub> – 0.15 V

## **Package Dimensions**

TSSOP56-P-0061-0.50A Unit: mm



Weight: 0.25 g (typ.)

#### **RESTRICTIONS ON PRODUCT USE**

20070701-EN GENERAL

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